Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | KIM ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0075750	04-2004	Bateman, John	348/231.1
*	В	US-6,429,896	08-2002	Aruga et al.	348/231.99
*	O	US-6,885,395	04-2005	Rabbani et al.	348/231.1
*	D	US-6,539,169	03-2003	Tsubaki et al.	386/109
*	Ε	US-2002/0109780	08-2002	Kaku, Junya	348/231.99
*	F	US-2002/0097326	07-2002	Kuroiwa, Toshihisa	348/231
	G	US-			
	Н	US-			
	ı	US-			
	7	US-	·		
	κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Q					
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NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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	8							
	x							

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.